GUARANTEED LOW SKEW CMOS CLOCK DRIVER/BUFFER

QS5805T/AT/BT
ADVANCE INFORMATION

FEATURES:

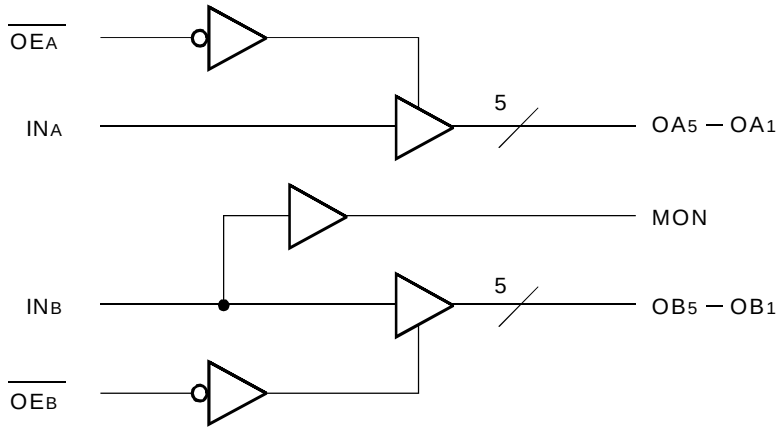
- 10 output, low skew signal buffer
- Guaranteed low skew:
  - 0.7ns output skew (same bank)
  - 0.9ns output skew (different bank)
  - 1ns part-to-part skew
- Input hysteresis for better noise margin
- Monitor output
- Undershoot clamp diodes on all inputs
- Std., A, and B speed grades
- Available in QSOP and SOIC packages

DESCRIPTION

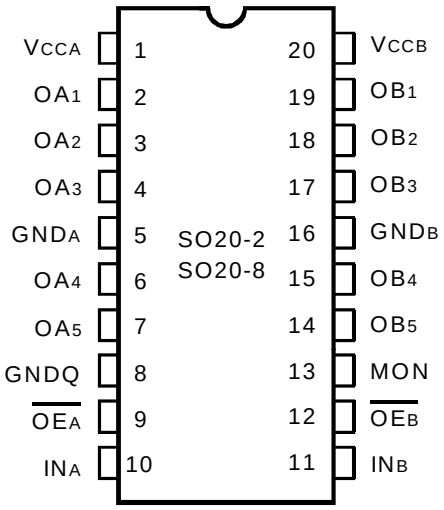
The QS5805T clock buffer/driver circuits can be used for clock buffering schemes where low skew is a key parameter. This device offers two banks of five non-inverting outputs. This device provides low propagation delay buffering with on-chip skew of 0.7ns for same-transition, same-bank signals.

The QS5805T is characterized for operation at -40°C to +85°C.

FUNCTIONAL BLOCK DIAGRAM



PIN CONFIGURATION



QSOP/ SOIC
TOP VIEW

ABSOLUTE MAXIMUM RATINGS (1)

Symbol	Description	Max.	Unit
V_{TERM}(2)	Supply Voltage to Ground	– 0.5 to +7	V
	DC Output Voltage V_{OUT}	– 0.5 to +7	V
V_{TERM}(3)	DC Input Voltage V_{IN}	– 0.5 to +7	V
V_{AC}	AC Input Voltage (pulse width ≤20ns)	-3	V
I_{OUT}	DC Input Diode Current V_{IN} < 0	-20	mA
	DC Output Current Max. Sink Current/Pin	120	mA
T_{STG}	Storage Temperature	– 65 to +150	°C
T_J	Junction Temperature	150	°C

NOTES:
1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. Vcc Terminals.
3. All terminals except Vcc.

CAPACITANCE (T_A = +25°C, f = 1.0MHz, V_{IN} = 0V)

Pins	Typ.	Max. (1)	Unit
C_{IN}	4	6	pF
C_{OUT}	7	9	pF

NOTE:
1. This parameter is guaranteed but not production tested.

PIN DESCRIPTION

Pin Names	I/O	Description
$\overline{OEA}$, $\overline{OEB}$	I	Output Enable Inputs
INA, INB	I	Clock Inputs
OAn, OBn	O	Clock Outputs
MON	O	Unbuffered Monitor Output

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:
Industrial: T_A = -40°C to +85°C, V_{CC} = 5.0V ± 10%

Symbol	Parameter	Test Conditions	Min.	Typ.(1)	Max.	Unit
V_{IH}	Input HIGH Voltage	Guaranteed Logic HIGH for All Inputs	2	—	—	V
V_{IL}	Input LOW Voltage	Guaranteed Logic LOW for All Inputs	—	—	0.8	V
V_{IC}	Clamp Diode Voltage (3)	Vcc = Min., I_{IN} = -18mA	—	–0.7	–1.2	V
V_{OH}	Output HIGH Voltage	Vcc = Min., I_{OH} = -24mA	2.4	—	—	V
		Vcc = Min., I_{OH} = -32mA	2	—	—	V
V_{OL}	Output LOW Voltage	Vcc = Min., I_{OL} = 64mA	—	—	0.55	V
I_{IN}	Input Leakage Current	Vcc = Max., V_{IN} = Vcc or GND	—	—	±1	µA
I_{OFF}	Input/Output Power Off Leakage	Vcc = 0V, V_{IN} or V_{OUT} = Vcc or GND	—	—	±1	µA
I_{OZ}	Output Leakage Current	Vcc = Max., V_{OUT} = Vcc or GND	—	—	±1	µA
I_{OS}	Short Circuit Current (2,3)	Vcc = Max., V_{OUT} = GND	–60	—	–250	mA
ΔV_T	Input Hysteresis	V_{TLH} - V_{THL} for All Inputs	—	0.2	—	V

NOTES:
1. Typical values are at V_{CC} = 5.0V, T_A = 25°C.
2. Not more than one output should be used to test this high power condition. Duration is less than one second.
3. Guaranteed by design but not tested.

POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions (1)		Typ. (3)	Max.	Unit
I_{CC}	Quiescent Power Supply Current	V_{CC} = Max., V_{IN} = GND or Vcc		0.005	0.5	mA
ΔI_{CC}	Supply Current per Input HIGH	V_{CC} = Max., V_{IN} = 3.4V, f_i = 0MHz		1	2.5	mA
I_{CCD}	Dynamic Power Supply Current per Output (2)	V_{CC} = Max., V_{IN} = GND or Vcc Outputs Enabled, 50% duty cycle		0.08	0.18	mA/MHz
I_C	Total Power Supply Current Examples (2,4)	V_{CC} = Max., $\overline{OEA}$ = $\overline{OEB}$ = GND	V_{IN} = GND or Vcc	4	9.5	mA
		50% duty cycle, f_i = 10MHz Five outputs toggling Unused inputs = GND or Vcc	V_{IN} = GND or 3.4V	4.5	10.8	
		V_{CC} = Max., $\overline{OEA}$ = $\overline{OEB}$ = GND	V_{IN} = GND or Vcc	2.2	5.5	
		50% duty cycle, f_i = 2.5MHz All outputs toggling	V_{IN} = GND or 3.4V	3.2	8	

NOTES:
1. For conditions shown as Min. or Max., use the appropriate values specified under DC Electrical Characteristics.
2. Guaranteed by design but not tested. C_L = 0pF.
3. Typical values are for reference only. Conditions are V_{CC} = 5.0V, T_A = 25°C.
4. $I_C = I_{CC} + (\Delta I_{CC})(D_H)(N_T) + I_{CCD}(f_O)(N_O)$
   where:
   D_H = Input Duty Cycle
   N_T = Number of TTL HIGH inputs at D_H (one or two)
   f_O = Output Frequency
   N_O = Number of outputs at f_O

SKEW CHARACTERISTICS OVER OPERATING RANGE

T_A = -40°C to +85°C, V_{CC} = 5.0V ± 10%
C_{LOAD} = 50pF; R_{LOAD} = 500Ω

Symbol	Parameter (1)	QS5805T		QS5805AT		QS5805BT		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
$t_{SK(01)}$	Skew between two outputs, same transition, same bank	—	0.7	—	0.7	—	0.7	ns
$t_{SK(02)}$	Skew between two outputs, same transition, different banks	—	0.9	—	0.9	—	0.9	ns
$t_{SK(P)}$	Pulse Skew; opposite transition skew, same output (t_{PHL} - t_{PLH})	—	0.7	—	0.7	—	0.7	ns
$t_{SK(T)}$	Part-to-part skew (2)	—	1.5	—	1	—	1	ns

NOTES:
1. Skew parameters are guaranteed across temperature range, but not tested. Skew parameters apply to propagation delays only.
2. $t_{SK(T)}$ only applies to devices of the same transition, part type, temperature, power supply voltage, loading, package, and speed grade.

SWITCHING CHARACTERISTICS OVER OPERATING RANGE

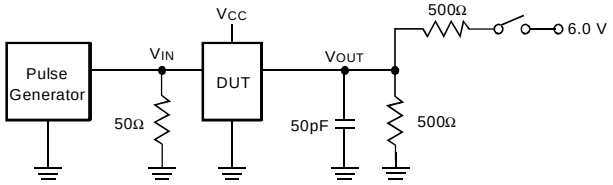
T_A = -40°C to +85°C, V_{CC} = 5.0V ± 10%
C_{LOAD} = 50pF; R_{LOAD} = 500Ω

Symbol	Parameter (1)	QS52805T		QS52805AT		QS5805BT		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t_{PLH} t_{PHL}	Propagation Delay (2)	1.5	6.5	1.5	5.8	1.5	5	ns
t_{PZL} t_{PZH}	Output Enable Time	1.5	8	1.5	8	1.5	7	ns
t_{PLZ} t_{PHZ}	Output Disable Time	1.5	7	1.5	7	1.5	6	ns
t_R	Output Rise Time, 0.8V to 2V (3)	—	1.5	—	1.5	—	1.5	ns
t_F	Output Fall Time, 2V to 0.8V (3)	—	1.5	—	1.5	—	1.5	ns

NOTES:
1. Minimums guaranteed but not production tested.
2. The propagation delay other range indicated by Min. and Max. specifications results from process and environmental variables. These propagation delays do not imply limit skew.
3. This parameter is guaranteed but not tested.

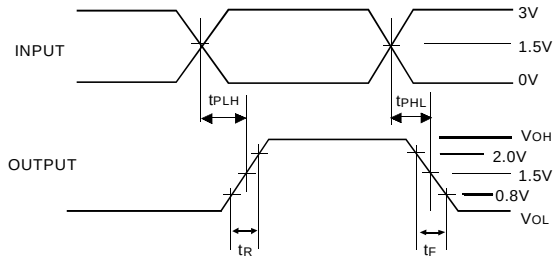
TEST CIRCUITS AND WAVEFORMS

Parameter Tested	Switch Position
t_{PLZ}, t_{PZL}	Closed
All Others	Open

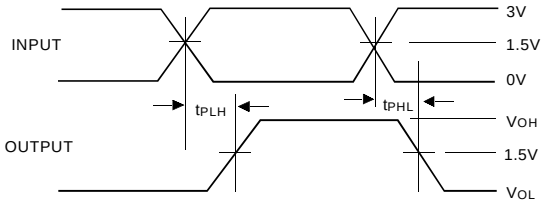


Pulse generator for all pulses: $f \leq 1.0MHz$; $t_F \leq 2.5ns$; $t_R \leq 2.5ns$

PROPAGATION DELAY

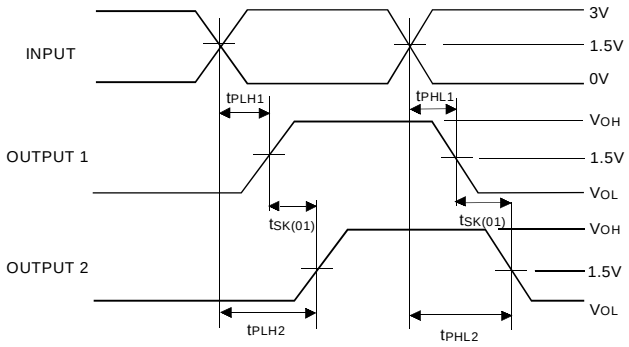


PULSE SKEW — $t_{SK(P)}$



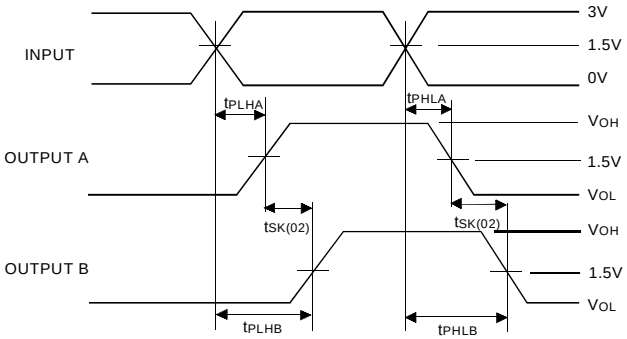
$t_{SK(p)} = |t_{PHL} - t_{PLH}|$

OUTPUT SKEW (SAME BANK) — $t_{SK(01)}$



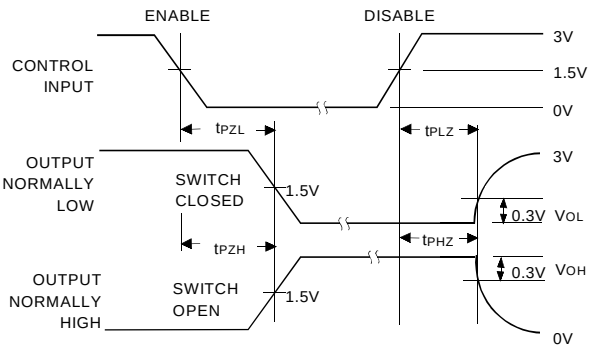
$t_{SK(01)} = |t_{PLH2} - t_{PLH1}|$ or $|t_{PHL2} - t_{PHL1}|$

OUPUT SKEW (DIFFERENT BANKS) — $t_{SK(02)}$

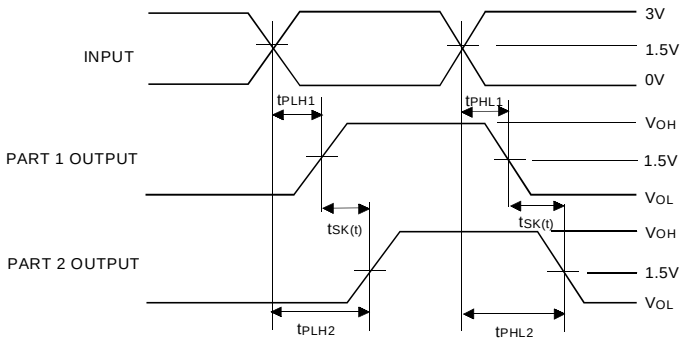


$t_{SK(02)} = |t_{PLHB} - t_{PLHA}|$ or $|t_{PHLB} - t_{PHLA}|$

ENABLE AND DISABLE TIMES

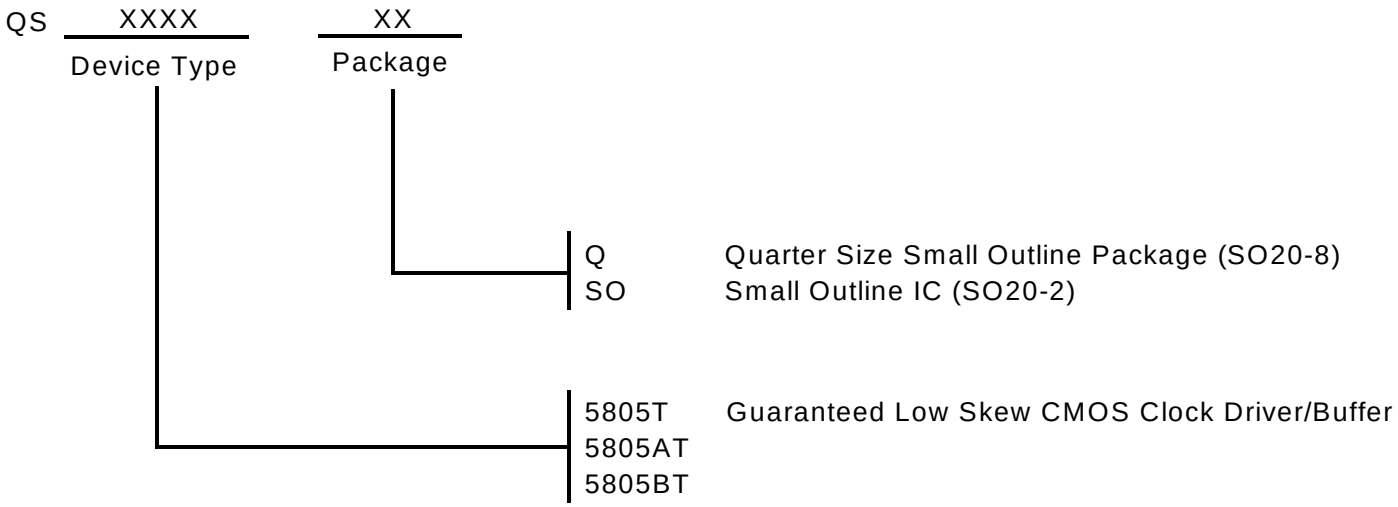


PART-TO-PART SKEW — $t_{SK(T)}$



$t_{SK(t)} = |t_{PLH2} - t_{PLH1}|$ or $|t_{PHL2} - t_{PHL1}|$

ORDERING INFORMATION



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